

Notice of References Cited	Application/Control No. 10/565,109	Applicant(s)/Patent Under Reexamination YABU ET AL.	
	Examiner Mohammad M. Ali	Art Unit 3744	Page 1 of 1

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*	B	US-6,813,894	11-2004	Maeda, Kensaku	62/93
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	U	Translation of JP 2001-241693 A of Boku et al.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.